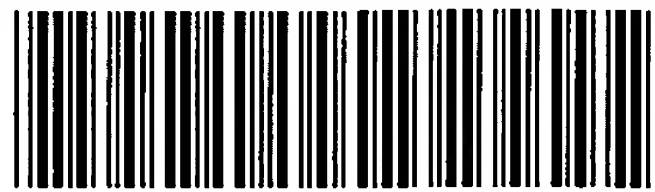


Search Notes (continued)



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/624,114	SCHICK ET AL.	
Examiner	Art Unit	
Ted Kim	3746	

SEARCHED			
Class	Subclass	Date	Examiner
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60	39.182	10/4/2006	TK

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PG-pub		10/4/2006	TK

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR